## Notice of References Cited Application/Control No. 10/823,513 Examiner Satish S. Rampuria Applicant(s)/Patent Under Reexamination CHANG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0225971 A1	12-2003	Oishi et al.	711/115
*	В	US-2003/0046447 A1	03-2003	Kouperchliak et al.	709/321
*	С	US-2002/0145632 A1	10-2002	Shmueli et al.	345/835
*	D	US-6,282,710 B1	08-2001	Boehler, Paul Joseph	717/174
*	E	US-2006/0173980 A1	08-2006	Kobayashi et al.	709/222
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	Wiener et al., Meeting USB and IEEE1394 overcurrent protection requirements using PolySwitch devices, IEEE, Nov 1997 Page(s): 442-475
	>	Remple, USB on-the-go interface for portable devices, IEEE, June 2003 Page(s): 8- 9
	v	Jankovec et al., Analog circuit development system, IEEE, Sept. 2003 Page(s): 125- 129 vol.1
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.